

Flagships: Imago Local Electrode Atom Probes

Local electrode atom probes for atomic-level analysis of materials

This world-leading facility provides comprehensive capabilities in atom probe tomography. Voltage-pulsed atom probe and pulsed-laser atom probe, open up this powerful technique to a large variety of applications, from conductive to less-conductive materials.

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Scientific Drivers

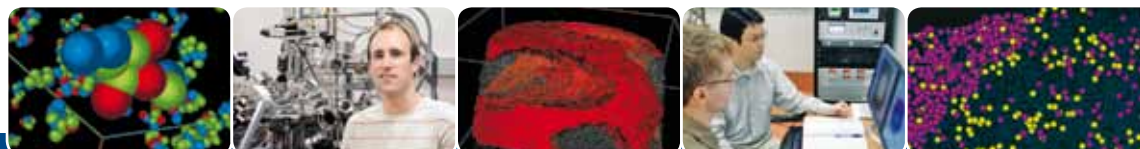
Many current scientific and technological challenges in the modern world require a better understanding of structure-property relationships in materials at the atomic scale. The range of these challenges is highly diverse, and includes designing clusters of solute atoms to strengthen advanced alloys such as light metals and new steels; and understanding how atomic distributions and impurities affect the functional properties of magnetic multilayers, nanowires, quantum dots, spintronic systems, and doped semiconductor devices. Atom probe tomography is without peer as a tool enabling the microscopic 3-D mapping, at the atomic level, of the location and chemistry of all elements of the periodic table, providing unique insights into many scientific and engineering challenges. While the voltage-pulsed system is largely limited to conductive materials, such as alloys and some semiconductors, the pulsed-laser atom probe allows the analysis of materials of very low conductivities, which means that studies involving semiconductors, ceramics and polymers become feasible.

Examples of the research that this platform will enable map across the National Research Priorities and include:

- Opening up entirely new research fields, such as experimentally-based materials informatics.
- Investigating the structures of interfaces within nano-structured advanced ceramics that exhibit dramatic improvements in toughness, often combined with other functional properties such as high ionic conductivity or piezoelectricity for sensors and transducers.
- Contributing to the development of new methodologies to apply this powerful tool to organic and biological materials, one of the stretch goals for the field of atom probe tomography.

Capabilities and the National Research Capacity

Atom probe tomography exploits the phenomenon of field and/or thermal ionisation of atoms at the tip of a sharp specimen when it is subjected to a large electrical potential or to a pico-second laser pulse. By measuring the time of flight of the resulting ions and their spatial positions when they strike the detector, the atom probe allows the original positions and chemical identities of millions of atoms to be determined in a single sample. The sample can then be reconstructed digitally in three dimensions, offering the ultimate in atomic microscopy.



The pulsed-laser atom probe is the only one in Australia and complements the voltage-pulsed atom probe at the University of Sydney. The laser-based platform greatly expands the types of materials available for 3-D atomic-level analysis to include ceramics, semiconductors, organics, glasses, oxide layers, and even biological materials. The wide field of view enables large datasets (many millions of atoms) to be captured. This is essential for the design of materials that rely on subtle atomic interactions.

The atom probe facility is a formidable technology that requires a highly specialised technical environment. Both the atom probes are sited together in the Australian Key Centre for Microscopy and Microanalysis to provide new users with access to a team of experienced technical personnel and researchers.

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Essential to optimal and productive use of this system, new users are also able to take advantage of the extensive know-how in advanced specimen preparation techniques, such as site-specific preparation methods, and the novel data analysis methods that have been developed at the University of Sydney. Take-up of the atom probe technology at this node is high, with researchers from universities, publicly funded research agencies and industry in Australia and overseas increasingly making use of the extensive capabilities of these instruments.

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